

EddyCus® TF inline SR – Sheet Resistance Monitoring System

P_T_inlineSR_2









Highlights

- ► Contact-free and realtime
- ► Accurate measurement
- ▶ High degree of versatility and flexibility
 - ► In- and ex-vacuo solutions
 - ► Fixed sensor and traverse solutions
 - ► Single-lane and multi-lane solutions
- ► High sample rate up to 1,000 measurements per second

Sensor Series

- ► Sheet resistance (Ohm/sq)
- Metal layer thickness (nm, μm)
- Metal substrate thickness (μm)
- Anisotropy
- ▶ Defects
- ▶ Integrity assessment

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Applications

- ► Architectural glass (LowE)
- ► Touch screens and flat monitors
- ▶ OLED and LED
- ► Smart-glass
- ► Transparent antistatic foils
- ► Photovoltaics
- ► Semiconductors
- ► De-icing and heating
- ▶ Batteries and fuel cells
- ► Packaging materials

Materials

- ► Metal films and meshes
- ▶ Conductive oxides
- Nanowire films
- ▶ Graphene, CNT, Graphite
- ▶ Printed films
- ► Conductive polymers (PEDOT:PSS)
- ▶ Other conductive films and materials

Engineered and Made in Germany





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Measurement technology	Non-contact eddy current sensor		
Substrates	Boules, ingots, wafer, foils, glass, etc.		
Measurement gap size	3 / 5 / 10 / 15 / 25 / 50 mm (other upon request)		
Number of sensor pairs / monitoring lanes	1-99		
Sensor sizes (W x L x H) in mm	Sensor M: 80 x 100 x 66 Sensor S: 34 x 48 x 117		
Conductive layers	Metals/TCOs/CNTs/ nanowires/ graphene/ grids/ PEDOT/ others		
Thickness measurement of metal films (e.g. Al, Ag, Mo, Ag paste)	1 nm – 2 mm (in accordance with sheet resistance)		
Other integrated measurements	Metal thickness / optical transmittance / density / anisotropy		
Environment	Ex-vacuo / in-vacuo @ T < 60°C / 140°F (higher on request)		
Sample rate	1 / 10 / 50 / 100 / 1,000 measurements per second		
Hardware trigger	5 / 12 / 24 V		
Interfaces	UDP, .Net libraries, TCP, Modbus, analog/digital		

	VLSR	LSR	MSR	HSR
	6 decades are measureable by one sensor, but with slightly affected accuracy			
Range [Ohm/sq]	0.0001 - 0.1	0.01 – 10	0.1 - 100	10 – 2,000
Accuracy / Bias		± 1%		±1-3%
Repeatability (2σ@1 Hz)		< 0.3%		< 0.5%

 $VLSR-Very\ Low\ Sheet\ Resistance\ ,\ LSR-Low\ Sheet\ Resistance\ ,\ MSR-Medium\ Sheet\ Resistance\ ,\ HSR-High\ Sheet\ Resistance\ ,$

Device Control and Software

- ► Several views and user levels
- ▶ Live view with upper and lower limits and alarm functions
- ► Analysis view providing statistics
- ▶ Can handle data of several thousands measurements per second
- ▶ Data storage into SQL database
- ► Customizable automated data export (csv, txt, xls,...)
- ► Several smart functions (automated DB cleaning, self-reference etc.)
- ► Parameterizable I/O modules (triggering of actions or alarms)

